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Examiner Initial *		Document No.	Date	Name		Class	Subclass		Filing Date	
Ш	AA	4,209,360	6/1980	Stenberg et al.		162	203		February 9,	1979
EU .	AB	4,619,737	10/1986	Holz		162	357		September 6, 1985	
44	AC	5,225,043	7/1993	Braun, et al.		162	301		December 4, 1991	
	AD					···				
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		Document No.	Date	Country		Class	Sub	class	Yes	No
Us	AL	WO 97/47803	12/1997	PCT		D21F	1/00)		x
4u	AM	EP 0 504 123	3/1992	Europe		D21F	9/00) .		х
ધ્ય	AN	EP 0 627 523	5/1994	Europe		D21F	9/0)		x
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	O'	THER REFEREN	ICES (INC	LUDING AUTHO	OR, TITLE, DA	TE, PERT	INENT	PAGES	s, etc.)	
4/1		K. Müller, A. E Corrugating M	Bubik and T edium", Jul	r. Schaible, "Gap ly,1991	Forming Techno	ology with	TWIN-	Former	G for Testline	r and
EXAMINE		in V		DATE CONSID		April				

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,					ATTORNEY DOCKET NO.: SERIAL NO: VOI0216.US 10/074,551						
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B	MADE	THE OFF		U.S PATENT	DOCUMENTS	3					
Examiner Initial *	TIADE	Document No.	Date	Name		Class	Sub	class	lass Filing Date		
EM.	AA	5,078,835	1/1992	Schiel, et al.		162	352		January 6,	, 1991	
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	AD							2			
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